

**Notice of References Cited**

Application/Control No.

10/064,494

Applicant(s)/Patent Under  
Reexamination  
NAKAZAWA, WATARU

Examiner

Michelle (Shelley) Thomson

Art Unit

3641

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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-5,395,152 A	03-1995	Skornicka et al.	296/124
	B	US-6,039,340	03-2000	Fischer, Anton	280/728.2
	C	US-5,564,739	10-1996	Davidson, Phillip K.	280/736
	D	US-5,456,488	10-1995	Bauer, John G.	280/728.1
	E	US-4,988,119	01-1991	Hartmeyer, James	280/728.2
	F	US-6,431,585	08-2002	Rickabus et al.	280/728.3
	G	US-4,720,147	01-1988	Takada, Juichiro	297/472
	H	US-6,540,251	04-2003	LeVey et al.	280/728.2
	I	US-5,775,859	07-1998	Anscher, Joseph	411/38
	J	US-6,508,486	01-2003	Welch et al.	280/730.2
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

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